FAIRCHILD SEMICONDUCTOR™

July 2008

# FDW2503NZ

## Dual N-Channel 2.5V Specified PowerTrench® MOSFET

### General Description

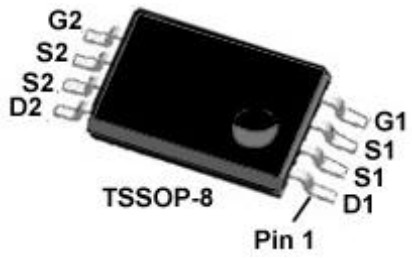
This NChannel 2.5V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V – 12V).

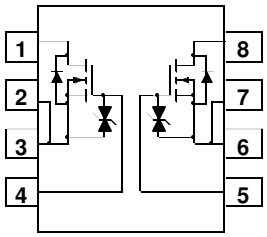
### Applications

- Load switch
- Motor drive
- DC/DC conversion
- Power management

### Features

- 5.5 A, 20 V. $R_{DS(ON)}$ = 20 mΩ @ $V_{GS}$ = 4.5V
  $R_{DS(ON)}$ = 26 mΩ @ $V_{GS}$ = 2.5V
- Extended $V_{GSS}$ range (±12V) for battery applications
- ESD protection diode (note 3)
- High performance trench technology for extremely low $R_{DS(ON)}$
- Low profile TSSOP-8 package




## Absolute Maximum Ratings

$T_A$=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|---|---|---|---|---|
| $V_{DSS}$ | Drain-Source Voltage | | 20 | V |
| $V_{GSS}$ | Gate-Source Voltage | | ±12 | V |
| $I_D$ | Drain Current – Continuous | (Note 1a) | 5.5 | A |
| | – Pulsed | | 30 | |
| $P_D$ | Power Dissipation | (Note 1a) | 1.0 | W |
| | | (Note 1b) | 0.6 | |
| $T_J$, $T_{STG}$ | Operating and Storage Junction Temperature Range | | –55 to +150 | °C |

## Thermal Characteristics

| | | | | |
|---|---|---|---|---|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1a) | 100 | °C/W |
| | | (Note 1b) | 125 | |

## Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|---|---|---|---|---|
| 2503NZ | FDW2503NZ | 13" | 12mm | 2500 units |

## Electrical Characteristics

$T_A$ = 25°C unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|---|---|---|---|---|---|---|
| **Off Characteristics** | | | | | | |
| $BV_{DSS}$ | Drain–Source Breakdown Voltage | $V_{GS}$ = 0 V, $I_D$ = 250 µA | 20 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D$ = 250 µA, Referenced to 25°C | | 14 | | mV/°C |
| $I_{DSS}$ | Zero Gate Voltage Drain Current | $V_{DS}$ = 16 V, $V_{GS}$ = 0 V | | | 1 | µA |
| $I_{GSSF}$ | Gate–Body Leakage, Forward | $V_{GS}$ = 12 V, $V_{DS}$ = 0 V | | | 10 | µA |
| $I_{GSSR}$ | Gate–Body Leakage, Reverse | $V_{GS}$ = –12 V, $V_{DS}$ = 0 V | | | –10 | µA |
| **On Characteristics** (Note 2) | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}$ = $V_{GS}$, $I_D$ = 250 µA | 0.6 | 1.0 | 1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D$ = 250 µA, Referenced to 25°C | | –3 | | mV/°C |
| $R_{DS(on)}$ | Static Drain–Source On–Resistance | $V_{GS}$ = 4.5 V, $I_D$ = 5.5 A<br>$V_{GS}$ = 2.5 V, $I_D$ = 5 A<br>$V_{GS}$ = 4.5 V, $I_D$ = 5.5 A, $T_J$=125°C | | 14<br>19<br>19 | 20<br>26<br>29 | mΩ |
| $I_{D(on)}$ | On–State Drain Current | $V_{GS}$ = 4.5 V, $V_{DS}$ = 5 V | 30 | | | A |
| $g_{FS}$ | Forward Transconductance | $V_{DS}$ = 5 V, $I_D$ = 5.5 A | | 30 | | S |
| **Dynamic Characteristics** | | | | | | |
| $C_{iss}$ | Input Capacitance | $V_{DS}$ = 10 V, $V_{GS}$ = 0 V, f = 1.0 MHz | | 1286 | | pF |
| $C_{oss}$ | Output Capacitance | | | 305 | | pF |
| $C_{rss}$ | Reverse Transfer Capacitance | | | 161 | | pF |
| **Switching Characteristics** (Note 2) | | | | | | |
| $t_{d(on)}$ | Turn–On Delay Time | $V_{DD}$ = 10 V, $I_D$ = 1 A, $V_{GS}$ = 4.5 V, $R_{GEN}$ = 6 Ω | | 10 | 20 | ns |
| $t_r$ | Turn–On Rise Time | | | 14 | 25 | ns |
| $t_{d(off)}$ | Turn–Off Delay Time | | | 25 | 40 | ns |
| $t_f$ | Turn–Off Fall Time | | | 8 | 16 | ns |
| $Q_g$ | Total Gate Charge | $V_{DS}$ = 10 V, $I_D$ = 5.5 A, $V_{GS}$ = 4.5 V | | 12 | 17 | nC |
| $Q_{gs}$ | Gate–Source Charge | | | 2.6 | | nC |
| $Q_{gd}$ | Gate–Drain Charge | | | 3 | | nC |
| **Drain–Source Diode Characteristics and Maximum Ratings** | | | | | | |
| $I_S$ | Maximum Continuous Drain–Source Diode Forward Current | | | | 1.0 | A |
| $V_{SD}$ | Drain–Source Diode Forward Voltage | $V_{GS}$ = 0 V, $I_S$ = 1.0 A (Note 2) | | 0.7 | 1.2 | V |

**Notes:**

**1.** $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

a) $R_{\theta JA}$ is 100°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.

b) $R_{\theta JA}$ is 125°C/W (steady state) when mounted on a minimum copper pad on FR-4.

**2.** Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

**3.** The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

## Typical Characteristics

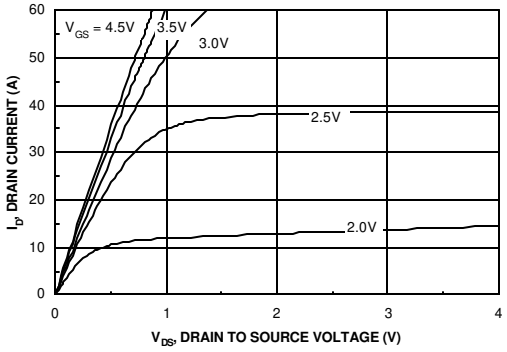



**Figure 1. On-Region Characteristics.**

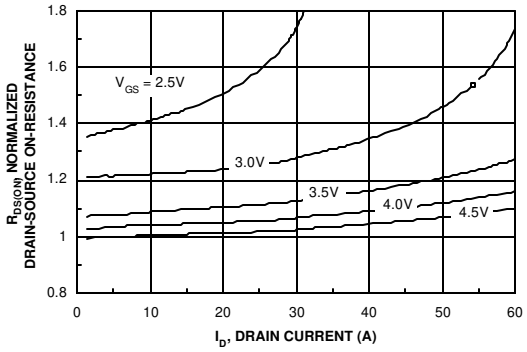



**Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.**

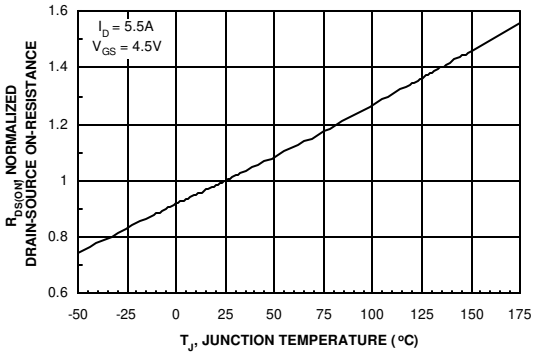



**Figure 3. On-Resistance Variation with Temperature.**

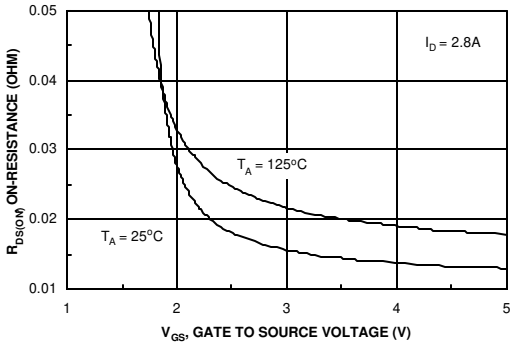



**Figure 4. On-Resistance Variation with Gate-to-Source Voltage.**

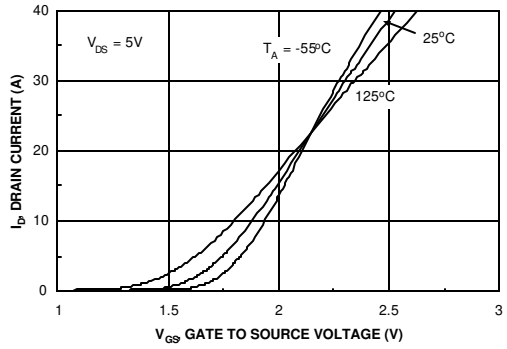



**Figure 5. Transfer Characteristics.**

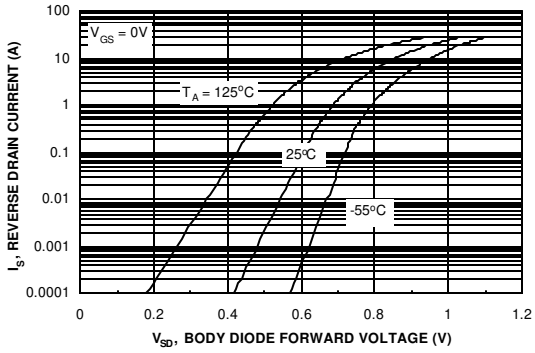



**Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.**

## Typical Characteristics

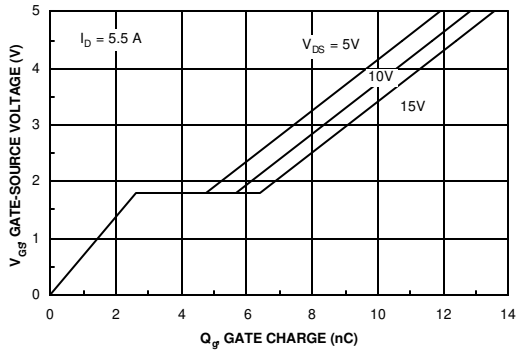



**Figure 7. Gate Charge Characteristics.**

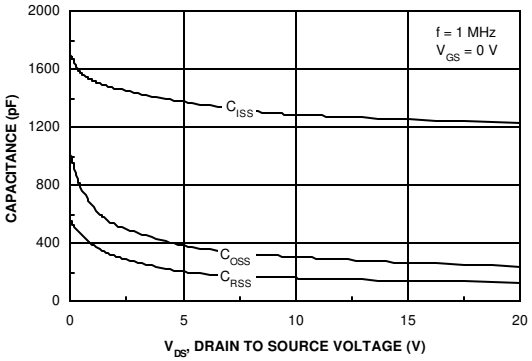



**Figure 8. Capacitance Characteristics.**

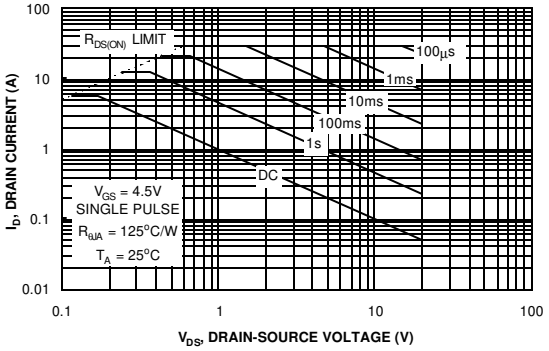



**Figure 9. Maximum Safe Operating Area.**

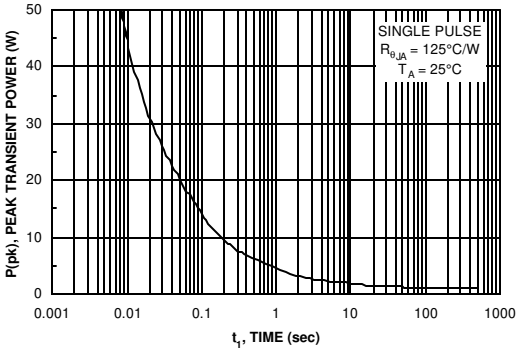



**Figure 10. Single Pulse Maximum Power Dissipation.**

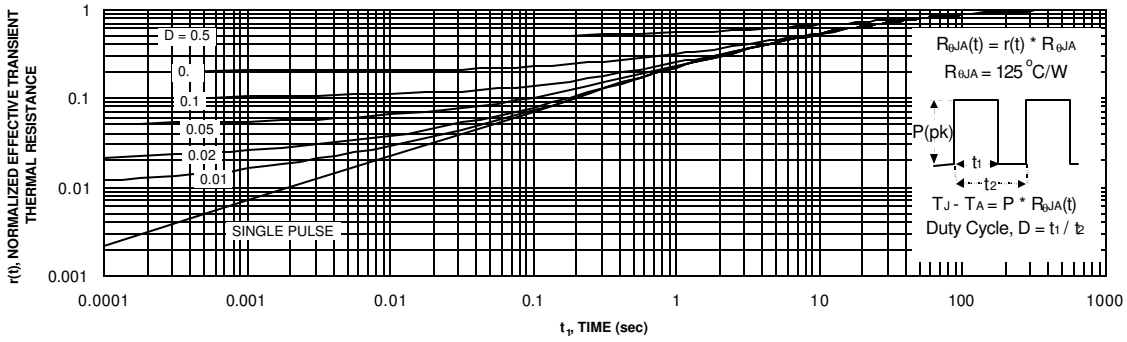



**Figure 11. Transient Thermal Response Curve.**

**Thermal characterization performed using the conditions described in Note 1b.**
**Transient thermal response will change depending on the circuit board design.**

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